

# **Excellent Integrated System Limited**

Stocking Distributor

Click to view price, real time Inventory, Delivery & Lifecycle Information:

Texas Instruments UCC2895QDWRQ1

For any questions, you can email us directly: <u>sales@integrated-circuit.com</u>





UCC2895-Q1

www.ti.com

SLUS783C - MAY 2008 - REVISED AUGUST 2012

# BICMOS ADVANCED PHASE-SHIFT PWM CONTROLLER

Check for Samples: UCC2895-Q1

#### FEATURES

- Qualified for Automotive Applications
- Programmable Output Turn-On Delay
- Bidirectional Oscillator Synchronization
- Voltage-Mode, Peak-Current-Mode, or Average-Current-Mode Control
- Programmable Soft Start/Soft Stop and Chip Disable Via a Single Pin
- 0% to 100% Duty-Cycle Control
- 7-MHz Error Amplifier
- Operation to 1 MHz
- Typical 5-mA Operating Current at 500 kHz
- Very Low 150-µA Current During Undervoltage Lockout (UVLO)

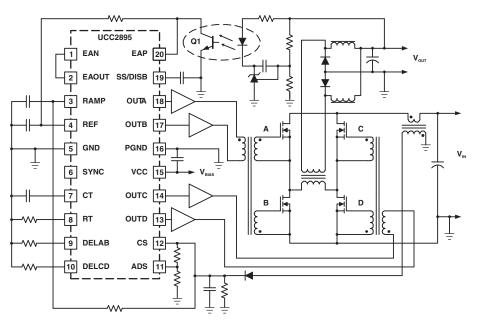
#### **APPLICATIONS**

- Phase-Shifted Full-Bridge Converters
- Off-Line, Telecom, Datacom, and Servers
- Distributed Power Architecture
- High-Density Power Modules

#### DESCRIPTION

The UCC2895-Q1 is a phase-shift pulse-width modulation (PWM) controller that implements control of a full-bridge power stage by phase shifting the switching of one half-bridge with respect to the other. It allows constant-frequency PWM in conjunction with resonant zero-voltage switching to provide high efficiency at high frequencies. The device can be used either as a voltage-mode or current-mode controller.

Although the UCC2895-Q1 maintains the functionality of the UC3875/6/7/8 family and UC3879, it improves on that controller family with additional features such as enhanced control logic, adaptive delay set, and shutdown capability. Because it is built using the BCDMOS process, it operates with dramatically less supply current than its bipolar counterparts. The UCC2895-Q1 can operate with a maximum clock frequency of 1 MHz.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

**A**A



#### UCC2895-Q1



www.ti.com

SLUS783C - MAY 2008 - REVISED AUGUST 2012

#### **ORDERING INFORMATION**<sup>(1)</sup>

T <sub>A</sub>	PACKAGE <sup>(2)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING				
-40°C to 125°C	SOIC – DW	Reel of 2000	UCC2895QDWRQ1	UCC2895Q				

For the most-current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI (1) Web site at www.ti.com.

(2)Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

EAN         1         20         EAP           EAOUT         2         19         SS/DISI           RAMP         3         18         OUTA           REF         4         17         OUTB	
RAMP         3         18         OUTA           REF         4         17         OUTB	
	βB
GND 5 16 PGND	
SYNC 6 15 VDD	
RT 2 8 13 0UTD	
DELAB 🔲 9 12 🗔 CS	
DELCD 10 11 ADS	

#### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

 $T_A = -40^{\circ}$ C to 125°C, all voltage values are with respect to the network ground terminal (unless otherwise noted)

			VALUE
V <sub>DD</sub>	Supply voltage	I <sub>DD</sub> < 10 mA	17 V
I <sub>DD</sub>	Supply current		30 mA
I <sub>REF</sub>	Reference current		15 mA
I <sub>O</sub>	Output current		100 mA
	Analog input voltage range	EAP, EAN, EAOUT, RAMP, SYNC, ADS, CS, SS/DISB	-0.3 V to REF + 0.3 V
	Drive output voltage range	OUTA, OUTB, OUTC, OUTD	–0.3 V to VDD + 0.3 V
PD	Power dissipation	$T_A = 25^{\circ}C$	650 mW
T <sub>stg</sub>	Storage temperature range		–65°C to 150°C
TJ	Junction temperature range		–55°C to 150°C
		Human-body model (HBM)	800 V
ESD	Electrostatic discharge protection	Machine model (MM)	200 V
	protocion	Charged-device model (CDM)	2000 V

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating (1) Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### **RECOMMENDED OPERATING CONDITIONS<sup>(1)</sup>**

			MIN	NOM	MAX	UNIT
$V_{DD}$	Supply voltage				16.5	V
$C_{VDD}$	Supply voltage bypass capacitor <sup>(2)</sup>			10 × C <sub>REF</sub>		μF
C <sub>REF</sub>	Reference bypass capacitor <sup>(3)</sup>		0.1		4.7	μF
CT	Timing capacitor	For 500-kHz switching frequency		220		pF
R <sub>T</sub>	Timing resistor	For 500-kHz switching frequency		82		kΩ

(1) It is recommended that there be a single point grounded between GND and PGND directly under the device. There should be a separate ground plane associated with the GND pin and all components associated with pins 1 through 12 plus 19 and 20 should be located over this ground plane. Any connections associated with these pins to ground should be connected to this ground plane. The V<sub>DD</sub> capacitor should be a low-ESR, -ESL ceramic capacitor located directly across the VDD and PGND pins. A larger bulk (2)

capacitor should be located as physically close as possible to the  $V_{DD}$  pins. The  $V_{REF}$  capacitor should be a low-ESR, -ESL ceramic capacitor located directly across the REF and GND pins. If a larger capacitor is (3)desired for V<sub>REF</sub>, then it should be located near the V<sub>REF</sub> capacitor and connected to the V<sub>REF</sub> pin with a resistor of 51 Ω or greater. The bulk capacitor on VDD must be a factor of 10 geater than the total V<sub>REF</sub> capacitance.

2 Submit Documentation Feedback Copyright © 2008–2012, Texas Instruments Incorporated



Www.ti.com

# UCC2895-Q1

SLUS783C - MAY 2008 - REVISED AUGUST 2012

# **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup> (continued)

	MIN	NOM MAX	UNIT
R <sub>DEL_AB</sub> Delay resistor R <sub>DEL_CD</sub>	2.5	40	kΩ
T <sub>J</sub> Operating junction temperature <sup>(4)</sup>	-55	125	°C

(4) It is not recommended that the device operate under conditions beyond those specified in this table for extended periods of time.

#### **ELECTRICAL CHARACTERISTICS**

 $V_{DD} = 12 \text{ V}, \text{ } \text{R}_{\text{T}} = 82 \text{ } \text{k}\Omega, \text{ } \text{C}_{\text{T}} = 220 \text{ pF}, \text{ } \text{R}_{\text{DELAB}} = 10 \text{ } \text{k}\Omega, \text{ } \text{R}_{\text{DELCD}} = 10 \text{ } \text{k}\Omega, \text{ } \text{C}_{\text{REF}} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{C}_{\text{VDD}} = 0.1 \text{ } \text{\mu}\text{F}, \text{ no load on the outputs, } \text{ } \text{T}_{\text{A}} = \text{T}_{\text{J}} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C} \text{ (unless otherwise noted)}$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Undervoltag	e Lockout (UVLO)						
UVLO <sub>(on)</sub>	Start-up voltage threshold		10.2	11	11.8	V	
UVLO <sub>(off)</sub>	Minimum operating voltage after start- up		8.2	9	9.8	V	
UVLO <sub>(hys)</sub>	Hysteresis		1	2	3	V	
Supply							
I <sub>START</sub>	Start-up current	V <sub>DD</sub> = 8 V		150	250	μA	
I <sub>DD</sub>	Operating current			5	6	mA	
V <sub>DD_CLAMP</sub>	VDD clamp voltage	I <sub>DD</sub> = 10 mA	16.5	17.5	18.5	V	
Voltage Refe	erence						
		$T_J = 25^{\circ}C$	4.94	5	5.06		
V <sub>REF</sub>	Output voltage		4.85	5	5.15	V	
I <sub>SC</sub>	Short-circuit current	REF = 0 V, T <sub>J</sub> = 25°C	10	20		mA	
Error Amplif	lier						
	Common-mode input voltage		-0.1		3.6	V	
V <sub>IO</sub>	Offset voltage		-7		7	mV	
I <sub>BIAS</sub>	Input bias current (EAP, EAN)		-1		1	μA	
V <sub>OH_EAOUT</sub>	High-level output voltage	$EAP - EAN = 500 \text{ mV}, I_{EAOUT} = -0.5 \text{ mA}$	4	4.5	5	V	
V <sub>OL_EAOUT</sub>	Low-level output voltage	$EAP - EAN = -500 \text{ mV}, I_{EAOUT} = 0.5 \text{ mA}$	0	0.2	0.4	V	
ISOURCE	Error amplifier output source current	EAP – EAN = 500 mV, EAOUT = 2.5 V	1	1.5		mA	
I <sub>SINK</sub>	Error amplifier output sink current	EAP – EAN = –500 mV, EAOUT = 2.5 V	2.5	4.5		mA	
A <sub>VOL</sub>	Open-loop dc gain		75	85		dB	
GBW	Unity gain bandwidth <sup>(1)</sup>		5	7		MHz	
	Slew rate <sup>(1)</sup>	1 V < EAN < 0 V, EAP = 500 mV, 0.5 V < EAOUT < 3 V	1.5	2.2		V/µs	
	No-load comparator turn-off threshold		0.45	0.5	0.55	V	
	No-load comparator turn-on threshold		0.55	0.6	0.69	V	
	No-load comparator hysteresis		0.035	0.1	0.165	V	
Oscillator							
f <sub>OSC</sub>	Frequency	$T_J = 25^{\circ}C$	473	500	527	kHz	
	Frequency total variation <sup>(1)</sup>	Over line and temperature		2.5%	5%		
V <sub>IH_SYNC</sub>	High-level input voltage, SYNC		2.05	2.1	2.4	V	
V <sub>OH_SYNC</sub>	High-level input voltage, SYNC	I <sub>SYNC</sub> = -400 μA, V <sub>CT</sub> = 2.6 V	4.1	4.5	5	V	
V <sub>OL_SYNC</sub>	Low-level output voltage, SYNC	I <sub>SYNC</sub> = 100 μA, V <sub>CT</sub> = 2.6 V	0	0.5	1	V	
	SYNC output pulse width	$LOAD_{SYNC}$ = 3.9 k $\Omega$ and 30 pF in parallel		85	135	ns	
V <sub>RT</sub>	Timing resistor voltage		2.9	3	3.1	V	
V <sub>CT(peak)</sub>	Timing capacitor peak voltage		2.25	2.35	2.55	V	
V <sub>CT(valley)</sub>	Timing capacitor valley voltage		0	0.2	0.4	V	

(1) Specified by design

Copyright © 2008–2012, Texas Instruments Incorporated

3



### UCC2895-Q1



www.ti.com

SLUS783C-MAY 2008-REVISED AUGUST 2012

#### **ELECTRICAL CHARACTERISTICS (continued)**

 $V_{DD} = 12 \text{ V}, \text{ } \text{R}_{\text{T}} = 82 \text{ } \text{k}\Omega, \text{ } \text{C}_{\text{T}} = 220 \text{ pF}, \text{ } \text{R}_{\text{DELAB}} = 10 \text{ } \text{k}\Omega, \text{ } \text{R}_{\text{DELCD}} = 10 \text{ } \text{k}\Omega, \text{ } \text{C}_{\text{REF}} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{C}_{\text{VDD}} = 0.1 \text{ } \text{\mu}\text{F}, \text{ no load on the outputs,} \text{ } \text{T}_{\text{A}} = \text{T}_{\text{J}} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C} \text{ (unless otherwise noted)}$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT				
Current Sense										
I <sub>CS(bias)</sub>	Current sense bias current	0 V < CS < 2.5 V, 0 V ADS < 2.5 V	-4.5		20	μA				
	Peak current threshold		1.9	2	2.1	V				
	Overcurrent threshold		2.4	2.5	2.6	V				
	Current sense to output delay	0 V ≤ CS ≤ 2.3 V, DELAB = DELCD = REF		75	110	ns				



www.ti.com

# UCC2895-Q1

SLUS783C - MAY 2008 - REVISED AUGUST 2012

#### **ELECTRICAL CHARACTERISTICS (continued)**

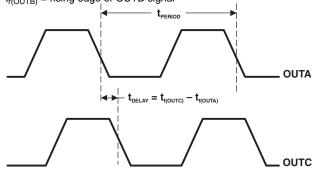
 $V_{DD} = 12 \text{ V}, \text{ } \text{R}_{\text{T}} = 82 \text{ } \text{k}\Omega, \text{ } \text{C}_{\text{T}} = 220 \text{ pF}, \text{ } \text{R}_{\text{DELAB}} = 10 \text{ } \text{k}\Omega, \text{ } \text{R}_{\text{DELCD}} = 10 \text{ } \text{k}\Omega, \text{ } \text{C}_{\text{REF}} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{C}_{\text{VDD}} = 0.1 \text{ } \text{\mu}\text{F}, \text{ no load on the outputs, } \text{ } \text{T}_{\text{A}} = \text{T}_{\text{J}} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C} \text{ (unless otherwise noted)}$ 

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
Soft Start/Shutdown								
ISOURCE	Soft-start source current	SS/DISB = 3 V, CS = 1.9 V	-40	-35	-30	μA		
I <sub>SINK</sub>	Soft-start sink current	SS/DISB = 3 V, CS = 2.6 V	325	350	375	μA		
	Soft-start/disable comparator threshold		0.44	0.5	0.56	V		
Adaptive D	elay Set (ADS)							
		ADS = CS = 0 V	0.45	0.5	0.55	N		
	DELAB/DELCD output voltage	ADS = 0 V, CS = 2 V	1.9	2	2.1	V		
t <sub>DELAY</sub>	Output delay <sup>(2) (3)</sup>	ADS = CS = 0 V	450	560	620	ns		
	ADS bias current	0 V < ADS < 2.5 V, 0 V < CS < 2.5 V	-20		20	μA		
Output								
V <sub>OH</sub>	High-level output voltage (all outputs)	$I_{OUT} = -10$ mA, VDD to output		250	420	mV		
V <sub>OL</sub>	Low-level output voltage (all outputs)	I <sub>OUT</sub> = 10 mA		150	270	mV		
t <sub>R</sub>	Rise time <sup>(2)</sup>	C <sub>LOAD</sub> = 100 pF		20	35	ns		
t <sub>F</sub>	Fall time <sup>(2)</sup>	C <sub>LOAD</sub> = 100 pF		20	35	ns		

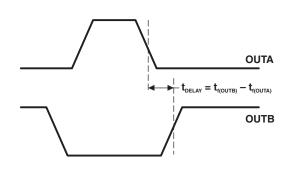
(2) Specified by design

(3) Output delay is measured between OUTA and OUTB or between OUTC and OUTD. Output delay is defined as shown in the following figure, where:

 $t_{f(OUTA)}$  = falling edge of OUTA signal  $t_{r(OUTB)}$  = rising edge of OUTB signal



Same applies to OUTB and OUTD



Same applies to OUTC and OUTD

5



### UCC2895-Q1



www.ti.com

SLUS783C - MAY 2008 - REVISED AUGUST 2012

#### **ELECTRICAL CHARACTERISTICS (continued)**

 $V_{DD} = 12 \text{ V}, \text{ } \text{R}_{T} = 82 \text{ } \text{k}\Omega, \text{ } \text{C}_{T} = 220 \text{ pF}, \text{ } \text{R}_{DELAB} = 10 \text{ } \text{k}\Omega, \text{ } \text{R}_{DELCD} = 10 \text{ } \text{k}\Omega, \text{ } \text{C}_{REF} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{C}_{VDD} = 0.1 \text{ } \text{\mu}\text{F}, \text{ no load on the outputs}, \text{ } \text{C}_{REF} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{C}_{VDD} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{no load on the outputs}, \text{ } \text{C}_{REF} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{C}_{VDD} = 0.1 \text{ } \text{\mu}\text{F}, \text{ } \text{no load on the outputs}, \text{ } \text{C}_{REF} = 0.1 \text{ } \text{L}^{2} \text{ } \text{C}_{VDD} = 0.1 \text{ } \text{L}^{2} \text{ } \text{C}_{VD} = 0.1$  $T_{\Delta} = T_{1} = -40^{\circ}$ C to 125°C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT				
PWM Comparator										
	EAOUT to RAMP input offset voltage	RAMP = 0 V, DELAB = DELCD = REF	0.7	0.85	1.05	V				
	Minimum phase shift <sup>(4)</sup> (OUTA to OUTC, OUTB to OUTD)	RAMP = 0 V, EAOUT = 650 mV	0	0.85%	1.5%					
t <sub>DELAY</sub>	Delay <sup>(5)</sup> (RAMP to OUTC, RAMP to OUTD)	0 V < RAMP < 2.5 V, EAOUT = 1.2 V, DELAB = DELCD = REF		70	120	ns				
I <sub>R(bias)</sub>	RAMP bias current	RAMP < 5 V, CT = 2.2 V	-5		5	μA				
I <sub>R(sink)</sub>	RAMP sink current	RAMP = 5 V, CT = 2.6 V	11	19		mA				

Minimum phase shift is defined as: (4)

or  $\Phi = 180 \times \frac{t_{f(OUTC)} - t_{f(OUTB)}}{t_{f(OUTB)}}$  $\Phi = 180 \times \frac{t_{f(OUTC)} - t_{f(OUTA)}}{t_{f(OUTC)}}$ t<sub>PERIOD</sub> t<sub>PERIOD</sub>

where:

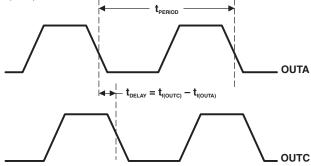
 $t_{f(OUTA)}$  = falling edge of OUTA signal  $t_{f(OUTB)}$  = falling edge of OUTB signal  $t_{f(OUTC)}$  = falling edge of OUTC signal

 $t_{f(OUTD)}$  = falling edge of OUTD signal

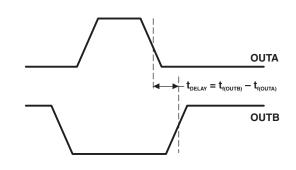
t<sub>PERIOD</sub> = period of OUTA or OUTB signal

(5) Output delay is measured between OUTA and OUTB or between OUTC and OUTD. Output delay is defined as shown in the following figure, where:

 $t_{f(OUTA)}$  = falling edge of OUTA signal  $t_{r(OUTB)}$  = rising edge of OUTB signal



Same applies to OUTB and OUTD



Same applies to OUTC and OUTD





www.ti.com

## UCC2895-Q1

SLUS783C - MAY 2008 - REVISED AUGUST 2012

#### **TERMINAL FUNCTIONS**

TERMI	NAL	1/0						
NAME	NO.	1/0	DESCRIPTION					
ADS	11	I	Adaptive delay set. Sets the ratio between the maximum and minimum programmed output delay dead time.					
CS	12	I	Current-sense input for cycle-by-cycle current limiting and for overcurrent comparator					
СТ	7	I	Oscillator timing capacitor for programming the switching frequency. The oscillator charges CT via a programmed current.					
DELAB	9	I	Delay programming between complementary outputs. DELAB programs the dead time between switching of output A and output B.					
DELCD	10	I	Delay programming between complementary outputs. DELCD programs the dead time between switching of output C and output D.					
EAOUT	2	I/O	Error amplifier output					
EAP	20	I	Noninverting input to the error amplifier. Keep below 3.6 V for proper operation.					
EAN	1	I	Inverting input to the error amplifier. Keep below 3.6 V for proper operation.					
GND	5	_	Ground for all circuits except the output stages					
OUTA	18	0						
OUTB	17	0	The four outputs are 100-mA CMOS drivers and are optimized to drive FET driver circuits such as the					
OUTC	14	0	UCC27424 or gate-drive transformers.					
OUTD	13	0						
PGND	16	-	Output-stage power ground					
RAMP	3	I	Inverting input of the PWM comparator					
REF	4	0	5-V $\pm$ 1.2% 5-mA voltage reference. For best performance, bypass with a 0.1- $\mu$ F low-ESR low-ESL capacitor to ground. Do not use more than 1 $\mu$ F of total capacitance on this pin.					
RT	8	I	Oscillator timing resistor for programming the switching frequency					
SS/DISB	19	Ι	Soft start/disable. This pin combines two independent functions.					
SYNC	6	I/O	Oscillator synchronization. This pin is bidirectional.					
VDD	15	Ι	Power-supply input. VDD must be bypassed with a minimum of a 1-µF low-ESR low-ESL capacitor to ground.					

7



#### UCC2895-Q1

SLUS783C - MAY 2008 - REVISED AUGUST 2012

FUNCTIONAL BLOCK DIAGRAM

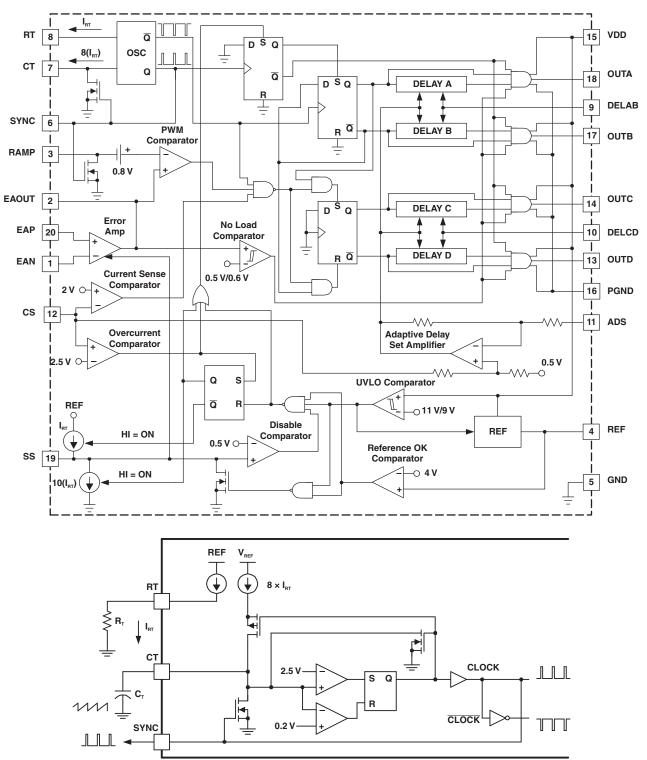


Figure 1. Oscillator Block Diagram

TEXAS INSTRUMENTS

www.ti.com



IEXAS INSTRUMENTS

#### UCC2895-Q1

www.ti.com

SLUS783C - MAY 2008 - REVISED AUGUST 2012

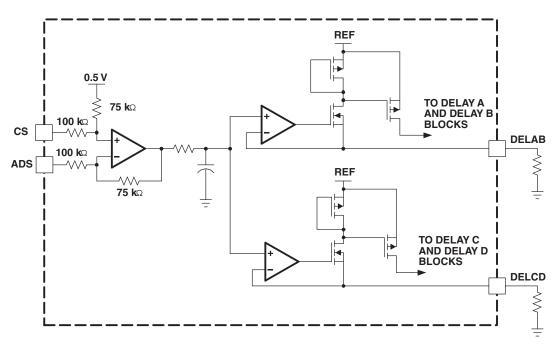
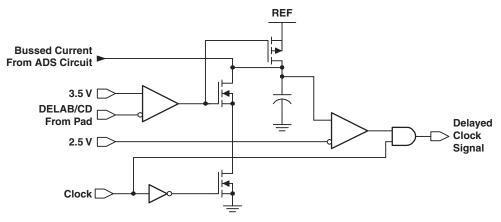


Figure 2. Adaptive Delay Setting Block Diagram





9



UCC2895-Q1

SLUS783C - MAY 2008 - REVISED AUGUST 2012

DETAILED PIN DESCRIPTIONS

#### Adaptive Delay Set (ADS)

This function sets the ratio between the maximum and minimum programmed output-delay dead time. When the ADS pin is directly connected to the CS pin, no delay modulation occurs. The maximum delay modulation occurs when ADS is grounded. In this case, delay time is four times longer when CS = 0 than when CS = 2 V (the peak-current threshold); ADS changes the output voltage on the delay pins DELAB and DELCD by Equation 1:

 $V_{DEL} = [0.75 \times (V_{CS} - V_{ADS})] + 0.5 V$ 

where  $V_{CS}$  and  $V_{ADS}$  are in volts. ADS must be limited to between 0 V and 2.5 V and must be less than or equal to CS. DELAB and DELCD are clamped to a minimum of 0.5 V.

(1)

(2)

(3)

#### Current Sense (CS)

CS is the inverting input of the current-sense comparator and the noninverting input of the overcurrent comparator and the ADS amplifier. The current-sense signal is used for cycle-by-cycle current limiting in peak-current mode control, and for overcurrent protection in all cases with a secondary threshold for output shutdown. An output disable initiated by an overcurrent fault also results in a restart cycle, called soft stop, with full soft start.

#### **Oscillator Timing Capacitor (CT)**

The oscillator charges CT via a programmed current. The waveform on CT is a sawtooth, with a peak voltage of 2.35 V. The approximate oscillator period is calculated by Equation 2:

 $t_{OSC} = [(5 \times R_T \times C_T)/48] + 120 \text{ ns}$ 

where  $C_T$  is in farads,  $R_T$  is in  $\Omega$ , and  $t_{OSC}$  is in seconds.  $C_T$  can range from 100 pF to 880 pF.

**NOTE** A large  $C_T$  and a small  $R_T$  combination results in extended fall times on the CT waveform. The increased fall time increases the SYNC pulse duration, hence limiting the maximum phase shift between OUTA, OUTB and OUTC, OUTD outputs, which limits the maximum duty cycle of the converter (see Figure 1).

#### Delay Programming Between Complementary Outputs (DELAB, DELCD)

DELAB programs the dead time between switching of OUTA and OUTB, and DELCD programs the dead time between OUTC and OUTD. This delay is introduced between complementary outputs in the same leg of the external bridge. The UCC2895N allows the user to select the delay, during which the resonant switching of the external power stages takes place. Separate delays are provided for the two half bridges to accommodate differences in resonant-capacitor charging currents. The delay in each stage is set according to Equation 3:

 $t_{DELAY} = [(25 \times 10^{-12} \times R_{DEL})/V_{DEL}] + 25 \text{ ns}$ 

where  $V_{DEL}$  is in volts,  $R_{DEL}$  is in ohms, and  $t_{DELAY}$  is in seconds. DELAB and DELCD can source approximately 1 mA maximum. Choose the delay resistors so that this maximum is not exceeded. Programmable output delay is defeated by tying DELAB and/or DELCD to REF. For optimum performance, keep stray capacitance on these pins at less than 10 pF.

#### Error Amplifier (EAOUT, EAP, EAN)

EAOUT is connected internally to the noninverting input of the PWM comparator and the no-load comparator. EAOUT is internally clamped to the soft-start voltage. The no-load comparator shuts down the output stages when EAOUT falls below 500 mV, and allows the outputs to turn on again when EAOUT rises above 600 mV.

EAP is the noninverting input and the EAN is the inverting input to the error amplifier.

INSTRUMENTS www.ti.com

(1)

(2)

(3)

TEXAS



www.ti.com

UCC2895-Q1

(4)

SLUS783C - MAY 2008 - REVISED AUGUST 2012

#### Output MOSFET Drivers (OUTA, OUTB, OUTC, OUTD)

The four outputs are 100-mA CMOS drivers and are optimized to drive MOSFET driver circuits. OUTA and OUTB are fully complementary, assuming no programming delay. They operate near 50% duty cycle and one-half the oscillator frequency. OUTA and OUTB are intended to drive one half-bridge circuit in an external power stage. OUTC and OUTD drive the other half-bridge circuit and have the same characteristics as OUTA and OUTB. OUTB. OUTC is phase shifted with respect to OUTA, and OUTD is phase shifted with respect to OUTB.

#### NOTE

Changing the phase relationship of OUTC and OUTD with respect to OUTA and OUTB requires other than the nominal 50% duty ratio on OUTC and OUTD during those transients.

#### **Power Ground (PGND)**

To keep output switching noise from critical analog circuits, the UCC2895-Q1 has two different ground connections. PGND is the ground connection for the high-current output stages. Both GND and PGND must be electrically tied together. Also, because PGND carries high current, board traces must be low-impedance.

#### Inverting Input of the PWM Comparator (RAMP)

This pin receives either the CT waveform in voltage control and average-current-mode control or the current signal (plus slope compensation) in peak-current-mode control.

#### Voltage Reference (REF)

The 5 V ± 1.2% reference supplies power to internal circuitry, and can also supply up to 5 mA to external loads. The reference is shut down during undervoltage lockout (UVLO) but is operational during all other disable modes. For best performance, bypass with a 0.1- $\mu$ F low-ESR low-ESL capacitor to GND. Do not use more than 1  $\mu$ F of total capacitance on this pin to ensure the stability of the internal reference.

#### **Oscillator Timing Resistor (RT)**

The oscillator operates by charging an external timing capacitor ( $C_T$ ) with a fixed current programmed by  $R_T$ .  $R_T$  current is calculated by Equation 4:

 $I_{RT}(A) = 3 V / R_T (\Omega)$ (4)

 $R_T$  can range from 40 k $\Omega$  to 120 k $\Omega.$  Soft-start charging and discharging currents are also programmed by  $I_{RT}$  (see Figure 1).

#### Analog Ground (GND)

This pin is the ground for all internal circuits except the output stages.



#### UCC2895-Q1

Texas Instruments

SLUS783C-MAY 2008-REVISED AUGUST 2012

www.ti.com

#### Soft Start/Disable (SS/DISB)

This pin combines two independent functions.

**Disable Mode:** A rapid shutdown of the chip is accomplished by externally forcing SS/DISB below 0.5 V, externally forcing REF below 4 V, or if VDD drops below the UVLO threshold. In the case of REF being pulled below 4 V or an undervoltage condition, SS/DISB is actively pulled to ground via an internal MOSFET switch.

If an overcurrent fault is sensed (CS = 2.5 V), a soft stop is initiated. In this mode, SS/DISB sinks a constant current of  $10 \times I_{RT}$ . The soft stop continues until SS/DISB falls below 0.5 V. When any of these faults is detected, all outputs are forced to ground immediately.

#### NOTE

If SS/DISB is forced below 0.5 V, the pin starts to source current equal to  $I_{RT}$ . The only time the device switches into low  $I_{DD}$  current mode is when the device is in UVLO.

**Soft-Start Mode:** After a fault or disable condition has passed, VDD is above the start threshold, or SS/DISB falls below 0.5 V during a soft stop, SS/DISB switches to a soft-start mode. The pin then sources current equal to  $I_{RT}$ . A user-selected resistor-and-capacitor combination on SS/DISB determines the soft-start time constant.

**NOTE** SS/DISB actively clamps the EAOUT pin voltage to approximately the SS/DISB pin voltage during both soft-start, soft-stop, and disable conditions.

#### **Oscillator Synchronization (SYNC)**

This pin is bidirectional (see Figure 1). When used as an output, SYNC can be used as a clock, which is the same as the internal clock of the device. When used as an input, SYNC overrides the internal oscillator of the device and acts as its clock signal. This bidirectional feature allows synchronization of multiple power supplies. Also, the SYNC signal internally discharges the  $C_T$  capacitor and any filter capacitors that are present on the RAMP pin. The internal SYNC circuitry is level-sensitive, with an input-low threshold of 1.9 V and an input-high threshold of 2.1 V. A resistor as small as 3.9 k $\Omega$  may be tied between SYNC and GND to reduce the SYNC pulse duration.

#### Chip Supply (VDD)

This is the input pin to the chip. VDD must be bypassed with a minimum of  $1-\mu F$  low-ESR low-ESL capacitor to ground.



www.ti.com

#### UCC2895-Q1

(5)

(6)

SLUS783C - MAY 2008 - REVISED AUGUST 2012

**APPLICATION INFORMATION** 

#### Programming DELAB, DELCD, and ADS

The UCC2895N allows the user to set the delay between switch commands within each leg of the full-bridge power circuit according to Equation 5:

 $t_{\text{DELAY}} = [(25 \times 10^{-12} \times R_{\text{DEL}})/V_{\text{DEL}}] + 25 \text{ ns}$ 

From Equation 5,  $V_{DEL}$  is determined in conjunction with the desire to use (or not use) the ADS feature from Equation 6:

 $V_{DEL} = [0.75 \times (V_{CS} - V_{ADS})] + 0.5 V$ 

Figure 4 illustrates the resistors needed to program the delay periods and the ADS function.

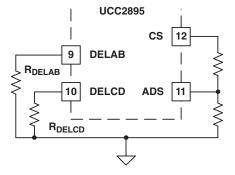


Figure 4. Programming Adaptive Delay Set

The ADS feature allows the user to vary the delay times between switch commands within each of the two legs of the converter. The delay-time modulation is implemented by connecting ADS (pin 11) to CS, GND, or a resistive divider from CS through ADS to GND to set  $V_{ADS}$  as shown in Figure 1. From Equation 6 for  $V_{DEL}$ , if ADS is tied to GND then  $V_{DEL}$  rises in direct proportion to  $V_{CS}$ , causing a decrease in  $t_{DELAY}$  as the load increases. In this condition, the maximum value of  $V_{DEL}$  is 2 V.

If ADS is connected to a resistive divider between CS and GND, the term ( $V_{CS} - V_{ADS}$ ) becomes smaller, reducing the level of  $V_{DEL}$ . This decreases the amount of delay modulation. In the limit of ADS tied to CS,  $V_{DEL} = 0.5$  V, and no delay modulation occurs. Figure 5 shows the delay time versus load for varying adaptive-delay-set feature voltages ( $V_{ADS}$ ).

In the case of maximum delay modulation (ADS = GND), when the circuit goes from light load to heavy load, the variation of  $V_{DEL}$  is from 0.5 V to 2 V. This causes the delay times to vary by a 4:1 ratio as the load is changed.

The ability to program an adaptive delay is a desirable feature, because the optimum delay time is a function of the current flowing in the primary winding of the transformer and can change by a factor of 10:1 or more as circuit loading changes. Reference [5] describes the many interrelated factors for choosing the optimum delay times for the most-efficient power conversion, and illustrates an external circuit to enable adaptive delay set using the UC3879. Implementing this adaptive feature is simplified in the UCC2895-Q1 controller, giving the user the ability to tailor the delay times to suit a particular application with a minimum of external parts.

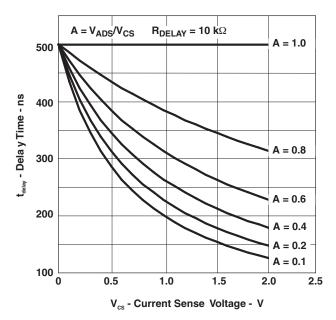


#### UCC2895-Q1



www.ti.com

SLUS783C - MAY 2008 - REVISED AUGUST 2012





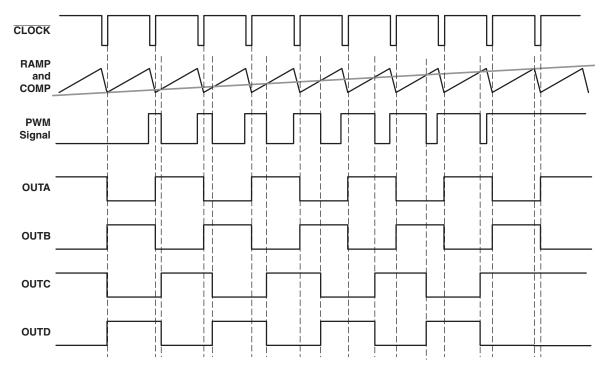


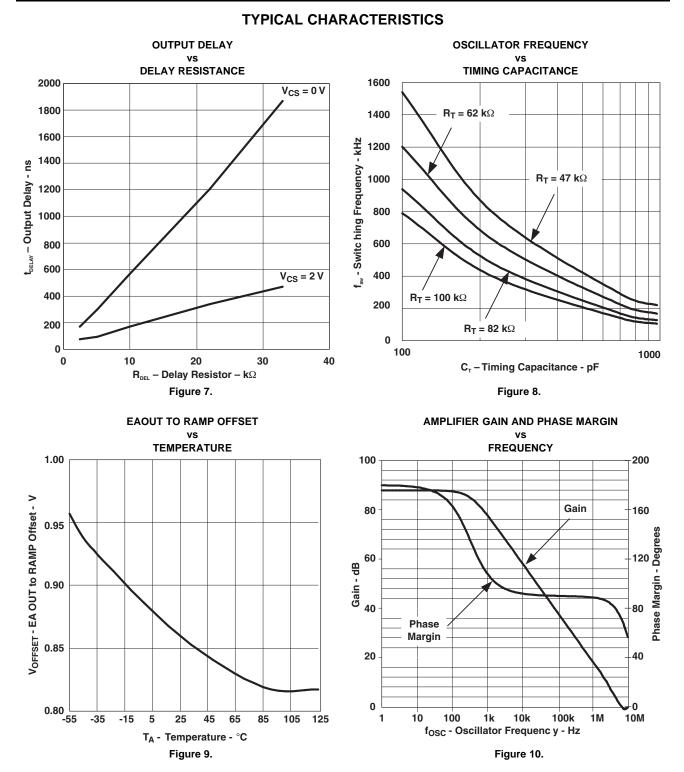
Figure 6. Timing Diagram (No Output Delay Shown, COMP to RAMP Offset Not Included)



www.ti.com

#### UCC2895-Q1

SLUS783C - MAY 2008 - REVISED AUGUST 2012



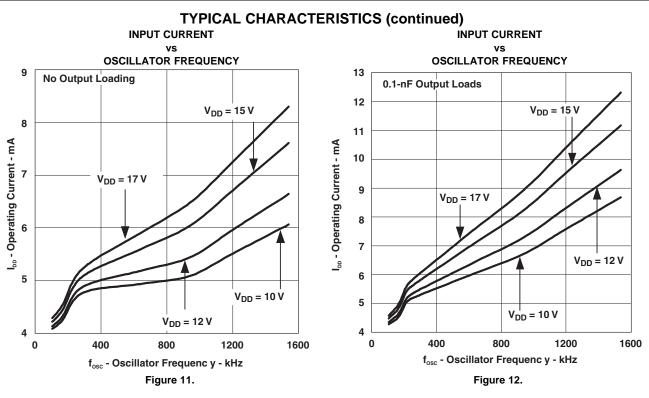


#### UCC2895-Q1



www.ti.com

SLUS783C - MAY 2008 - REVISED AUGUST 2012



#### REFERENCES

- 1. M. Dennis, A Comparison Between the BiCMOS UCC2895 Phase Shift Controller and the UC3875 (SLUA246)
- 2. L. Balogh, The Current-Doubler Rectifier: An Alternative Rectification Technique For Push-Pull and Bridge Converters (SLUA121)
- W. Andreycak, Phase Shifted, Zero Voltage Transition Design Considerations and the UC3875 PWM Controller (SLUA107)
- 4. L. Balogh, The New UC3879 Phase-Shifted PWM Controller Simplifies the Design of Zero Voltage Transition Full-Bridge Converters (SLUA122)
- 5. L. Balogh, Design Review: 100 W, 400 kHz, dc-to-dc Converter with Current Doubler Synchronous Rectification Achieves 92% Efficiency, Unitrode Power Supply Design Seminar Manual, SEM-1100, 1996, Topic 2.
- 6. UC3875 Phase Shift Resonant Controller data sheet (SLUS229)
- 7. UC3879 Phase Shift Resonant Controller data sheet (SLUS230)
- 8. Configuring the UCC2895 for Direct Control Driven Synchronous Rectification (SLUU109)
- 9. S. Mappus, UCC2895 OUTC/OUTD Asymetric Duty Cycle Operation (SLUA275)
- 10. S. Mappus, Current Doubler Rectifier Offers Ripple Current Cancellation (SLUA323)
- 11. S. Mappus, Control Driven Synchronous Rectifiers In Phase Shifted Full Bridge Converters (SLUA287)



# UCC2895-Q1

SLUS783C - MAY 2008 - REVISED AUGUST 2012

#### **REVISION HISTORY**

Changes f	from	Povision	D	/ huby	2012	+	Povision	C
Changes	nom	Revision	D	July	2012	10	Revision	J.

#### Page

•	Changed T <sub>J</sub> from -40°C to -55°C	2
•	Changed T <sub>J</sub> from -40°C to -55°C	3



11-Apr-2013

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins		Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
UCC2895QDWRQ1	ACTIVE	SOIC	DW	20	2000	Green (RoHS	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 125	UCC2895Q	Samples
						& no Sb/Br)					bampies

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs. LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design. PREVIEW: Device has been announced but is not in production. Samples may or may not be available. OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD:** The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above. Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF UCC2895-Q1 :

Catalog: UCC2895

Addendum-Page 1



11-Apr-2013

Enhanced Product: UCC2895-EP

- NOTE: Qualified Version Definitions:
  - Catalog TI's standard catalog product
  - Enhanced Product Supports Defense, Aerospace and Medical Applications

Addendum-Page 2

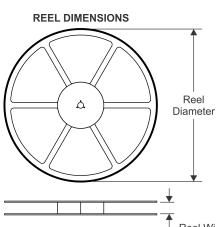


#### **Distributor of Texas Instruments: Excellent Integrated System Limited** Datasheet of UCC2895QDWRQ1 - IC REG CTRLR ISO PWM 20-SOIC Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

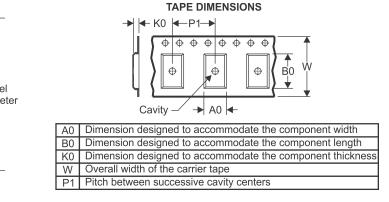
TEXAS INSTRUMENTS

# PACKAGE MATERIALS INFORMATION

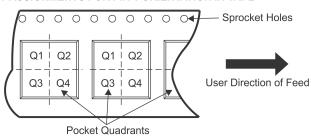
20-Dec-2013



TAPE AND REEL INFORMATION



# Reel Width (W1) QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



	*All o	dimensions	are	nominal	
--	--------	------------	-----	---------	--

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
UCC2895QDWRQ1	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1

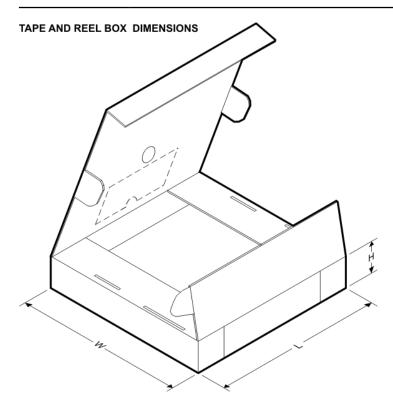


**Distributor of Texas Instruments: Excellent Integrated System Limited** Datasheet of UCC2895QDWRQ1 - IC REG CTRLR ISO PWM 20-SOIC Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com



# PACKAGE MATERIALS INFORMATION

20-Dec-2013



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
UCC2895QDWRQ1	SOIC	DW	20	2000	367.0	367.0	45.0



**DW0020A** 

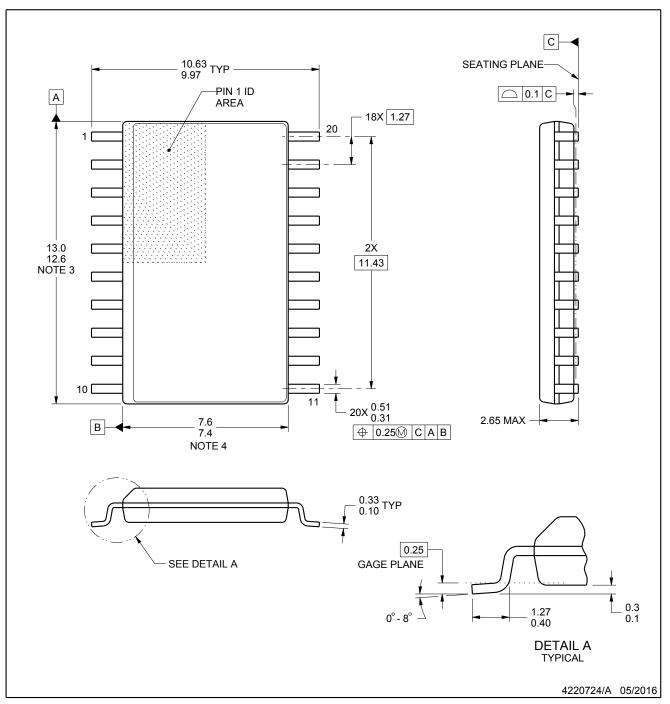
**Distributor of Texas Instruments: Excellent Integrated System Limited** Datasheet of UCC2895QDWRQ1 - IC REG CTRLR ISO PWM 20-SOIC Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com



# PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.





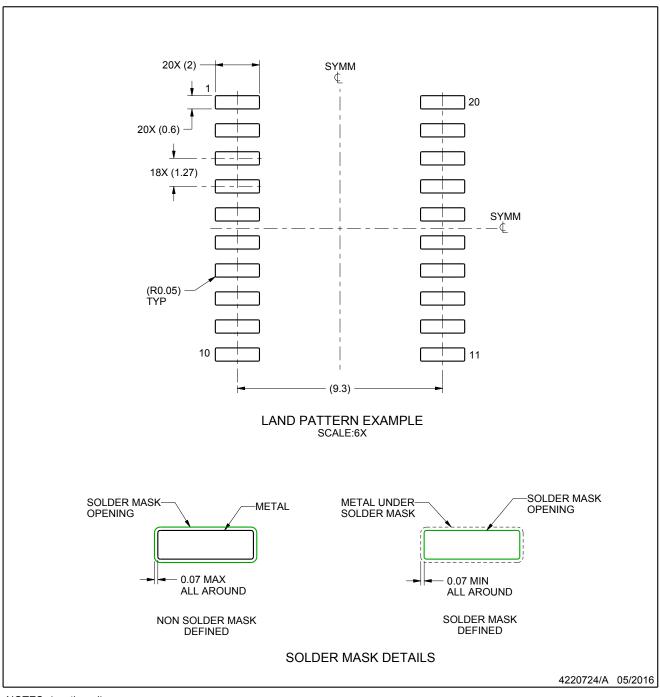
**DW0020A** 

**Distributor of Texas Instruments: Excellent Integrated System Limited** Datasheet of UCC2895QDWRQ1 - IC REG CTRLR ISO PWM 20-SOIC Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

# **EXAMPLE BOARD LAYOUT**

#### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





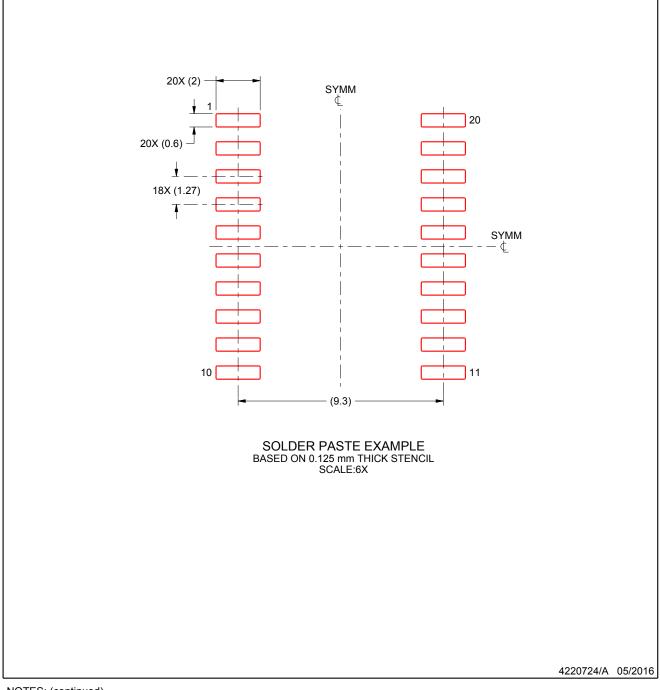
**DW0020A** 

**Distributor of Texas Instruments: Excellent Integrated System Limited** Datasheet of UCC2895QDWRQ1 - IC REG CTRLR ISO PWM 20-SOIC Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com

# **EXAMPLE STENCIL DESIGN**

#### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.





#### **IMPORTANT NOTICE**

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products		Applications	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
DSP	dsp.ti.com	Energy and Lighting	www.ti.com/energy
Clocks and Timers	www.ti.com/clocks	Industrial	www.ti.com/industrial
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Security	www.ti.com/security
Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Applications Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com
Wireless Connectivity	www.ti.com/wirelessconne	ctivity	

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2016, Texas Instruments Incorporated